## Memory FRAM

## 1 M Bit (64 K $\times 16$ )

## MB85R1002A

## ■ DESCRIPTIONS

The MB85R1002A is an FRAM (Ferroelectric Random Access Memory) chip consisting of 65,536 words $\times$ 16 bits of nonvolatile memory cells fabricated using ferroelectric process and silicon gate CMOS process technologies.
The MB85R1002A is able to retain data without using a back-up battery, as is needed for SRAM. The memory cells used in the MB85R1002A can be used for $10^{10}$ read/write operations, which is a significant improvement over the number of read and write operations supported by Flash memory and E²PROM. The MB85R1002A uses a pseudo-SRAM interface that is compatible with conventional asynchronous SRAM.

## - FEATURES

- Bit configuration : 65,536 words $\times 16$ bits
- Read/write endurance : $10^{10}$ times
- Operating power supply voltage : 3.0 V to 3.6 V
- Operating temperature range
$:-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$
- Data retention
: 10 years $\left(+55^{\circ} \mathrm{C}\right)$
- $\overline{\mathrm{LB}}$ and $\overline{\mathrm{UB}}$ data byte control
- Package
: 48-pin plastic TSOP (1)


## MB85R1002A

## PIN ASSIGNMENTS

(TOP VIEW)

(FPT-48P-M48)

## PIN DESCRIPTIONS

| Pin Number | Pin Name | Functional Description |
| :---: | :---: | :--- |
| 1 to 8,18 to 25 | A 0 to A 15 | Address Input pins |
| 29 to 36,38 to 45 | $\mathrm{I} / \mathrm{O} 1$ to I/O16 | Data Input/Output pins |
| 26 | $\overline{\mathrm{CE}} 1$ | Chip Enable 1 Input pin |
| 12 | CE 2 | Chip Enable 2 Input pin |
| 11 | $\overline{\mathrm{WE}}$ | Write Enable Input pin |
| 28 | $\overline{\mathrm{OE}}$ | Output Enable Input pin |
| 14,15 | $\overline{\mathrm{LB}}, \overline{\mathrm{UB}}$ | Data Byte Control Input pins |
| 16,37 | VDD | Supply Voltage pins <br> Connect all two pins to the power supply. |
| $13,27,46$ | VSS | Ground pins <br> Connect all three pins to ground. |
| $9,10,17,47,48$ | NC | No Connect pins |

## BLOCK DIAGRAM



## MB85R1002A

■ FUNCTIONAL TRUTH TABLE

| Mode | CE1 | CE2 | $\overline{W E}$ | $\overline{O E}$ | $\overline{\text { LB }}$ | $\overline{\text { UB }}$ | I／01 to I／08 | I／09 to／／016 | Supply Current |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Standby Precharge | H | X | X | X | X | X | Hi－Z | Hi－Z | Standby （Iss） |
|  | X | L | X | X | X | X |  |  |  |
|  | X | X | H | H | X | X |  |  |  |
|  | X | X | X | X | H | H |  |  |  |
| Read | z | H | H | L | L | L | Data Output | Data Output | Operation （Icc） |
|  |  |  |  |  | L | H | Data Output | Hi－Z |  |
|  |  |  |  |  | H | L | Hi－Z | Data Output |  |
|  | L | ¢ | H | L | L | L | Data Output | Data Output |  |
|  |  |  |  |  | L | H | Data Output | Hi－Z |  |
|  |  |  |  |  | H | L | Hi－Z | Data Output |  |
| $\begin{gathered} \text { Read } \\ \text { (Pseudo-SRAM, } \\ \hline \mathrm{OE} \text { control } \end{gathered}$ | L | H | H | 飞 | L | L | Data Output | Data Output |  |
|  |  |  |  |  | L | H | Data Output | Hi－Z |  |
|  |  |  |  |  | H | L | Hi－Z | Data Output |  |
| Write | 飞 | H | L | H | L | L | Data Input | Data Input |  |
|  |  |  |  |  | L | H | Data Input | Hi－Z |  |
|  |  |  |  |  | H | L | Hi－Z | Data Input |  |
|  | L | $\checkmark$ | L | H | L | L | Data Input | Data Input |  |
|  |  |  |  |  | L | H | Data Input | Hi－Z |  |
|  |  |  |  |  | H | L | Hi－Z | Data Input |  |
| Write （Pseudo－SRAM， WE control＊2） | L | H | を | H | L | L | Data Input | Data Input |  |
|  |  |  |  |  | L | H | Data Input | Hi－Z |  |
|  |  |  |  |  | H | L | Hi－Z | Data Input |  |

Note： $\mathrm{L}=\mathrm{V}_{\mathrm{IL}}, \mathrm{H}=\mathrm{V}_{\mathrm{IH}}, \mathrm{X}$ can be either $\mathrm{V}_{\mathrm{IL}}$ or $\mathrm{V}_{\mathrm{IH}}, \mathrm{Hi}-\mathrm{Z}=$ High Impedance
$₹$ ：Latch address and latch data at falling edge，$\sqrt{ }$ ：Latch address and latch data at rising edge
＊1：$\overline{\mathrm{OE}}$ control of the Pseudo－SRAM means the valid address at the falling edge of $\overline{\mathrm{OE}}$ to read．
＊2 ：$\overline{\mathrm{WE}}$ control of the Pseudo－SRAM means the valid address and data at the falling edge of $\overline{\mathrm{WE}}$ to write．

## ABSOLUTE MAXIMUM RATINGS

| Parameter |  | Symbol | Rating |  |
| :--- | :---: | :---: | :---: | :---: |
|  |  |  |  |  |
| Power Supply Voltage* $^{*}$ |  | Min |  |  |
| Input Pin Voltage* $^{*}$ | $\mathrm{~V}_{\mathrm{cc}}$ | -0.5 | V | V |
| Output Pin Voltage* | $\mathrm{V}_{\mathrm{IN}}$ | -0.5 | $\mathrm{~V}_{\mathrm{cc}}+0.5(\leq 4.0)$ | V |
| Operating Temperature | $\mathrm{V}_{\text {out }}$ | -0.5 | $\mathrm{~V}_{\mathrm{cc}}+0.5(\leq 4.0)$ | V |
| Storage Temperature | $\mathrm{T}_{\mathrm{A}}$ | -40 | +85 | ${ }^{\circ} \mathrm{C}$ |

* : All voltages are referenced to VSS $=0 \mathrm{~V}$.

WARNING: Semiconductor devices can be permanently damaged by application of stress (voltage, current, temperature, etc.) in excess of absolute maximum ratings. Do not exceed these ratings.

■ RECOMMENDED OPERATING CONDITIONS

| Parameter | Symbol | Value |  |  | Unit |
| :--- | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Typ | Max |  |
| Power Supply Voltage $^{*}$ | $\mathrm{~V}_{\mathrm{cc}}$ | 3.0 | 3.3 | 3.6 | V |
| High Level Input Voltage* | $\mathrm{V}_{\mathrm{H}}$ | $\mathrm{V}_{\mathrm{cc}} \times 0.8$ | - | $\mathrm{V}_{\mathrm{cc}}+0.5$ <br> $(\leq 4.0)$ | V |
| Low Level Input Voltage* | $\mathrm{V}_{\mathrm{IL}}$ | -0.5 | - | +0.6 | V |
| Operating Temperature | $\mathrm{T}_{\mathrm{A}}$ | -40 | - | +85 | ${ }^{\circ} \mathrm{C}$ |

* : All voltages are referenced to VSS $=0 \mathrm{~V}$.

WARNING: The recommended operating conditions are required in order to ensure the normal operation of the semiconductor device. All of the device's electrical characteristics are warranted when the device is operated within these ranges.
Always use semiconductor devices within their recommended operating condition ranges. Operation outside these ranges may adversely affect reliability and could result in device failure. No warranty is made with respect to uses, operating conditions, or combinations not represented on the data sheet. Users considering application outside the listed conditions are advised to contact their representatives beforehand.

## MB85R1002A

## ■ ELECTRICAL CHARACTERISTICS

1. DC Characteristics
(within recommended operating conditions)

| Parameter | Symbol | Condition | Value |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | Min | Typ | Max |  |
| Input Leakage Current | \|lı| | $\mathrm{V}_{\text {In }}=0 \mathrm{~V}$ to Vcc | - | - | 10 | $\mu \mathrm{A}$ |
| Output Leakage Current | \|ILO| | $\begin{aligned} & \text { Vout }=0 \mathrm{~V} \text { to } \mathrm{V}_{\mathrm{cc}}, \\ & \overline{\mathrm{CE}} 1=\mathrm{V}_{\mathrm{H}} \text { or } \overline{\mathrm{OE}}=\mathrm{V}_{\mathrm{H}} \end{aligned}$ | - | - | 10 | $\mu \mathrm{A}$ |
| Operating Power Supply Current | Icc | $\begin{aligned} & \overline{\mathrm{CE}} 1=0.2 \mathrm{~V}, \mathrm{CE} 2= \\ & \mathrm{V} \mathrm{cc}-0.2 \mathrm{~V}, \\ & \text { lout }=0 \mathrm{~mA}^{\star 1} \end{aligned}$ | - | 10 | 15 | mA |
| Standby Current | Isb | $\overline{\mathrm{CE}} 1 \geq \mathrm{Vcc}-0.2 \mathrm{~V}$ | - | 10 | 50 | $\mu \mathrm{A}$ |
|  |  | CE2 $\leq 0.2 \mathrm{~V}^{*}$ |  |  |  |  |
|  |  | $\begin{aligned} & \overline{\mathrm{OE}} \geq \mathrm{V}_{\mathrm{cc}}-0.2 \mathrm{~V}, \overline{\mathrm{WE}} \geq \\ & \mathrm{V}_{\mathrm{cc}}-0.2 \mathrm{~V}^{* 2} \end{aligned}$ |  |  |  |  |
|  |  | $\begin{aligned} & \overline{\mathrm{LB}} \geq \mathrm{V}_{\mathrm{cc}}-0.2 \mathrm{~V}, \overline{\mathrm{UB}} \geq \\ & \mathrm{V}_{\mathrm{cc}}-0.2 \mathrm{~V}^{* 2} \end{aligned}$ |  |  |  |  |
| High Level Output Voltage | Vor | $\mathrm{I} \mathrm{O}=-1.0 \mathrm{~mA}$ | Vcc $\times 0.8$ | - | - | V |
| Low Level Output Voltage | Vol | $\mathrm{loL}=2.0 \mathrm{~mA}$ | - | - | 0.4 | V |

*1 : During the measurement of Icc , the Address, Data In were taken to only change once per active cycle. lout : output current
*2 : All pins other than setting pins should be input at the CMOS level voltages such as $\mathrm{H} \geq \mathrm{Vcc}-0.2 \mathrm{~V}, \mathrm{~L} \leq 0.2 \mathrm{~V}$.

## 2. AC Characteristics

## - AC Test Conditions

| Supply Voltage | $: 3.0 \mathrm{~V}$ to 3.6 V |
| :--- | :--- |
| Operating Temperature | $:-40{ }^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |
| Input Voltage Amplitude | $: 0.3 \mathrm{~V}$ to 2.7 V |
| Input Rising Time | $: 5 \mathrm{~ns}$ |
| Input Falling Time | $: 5 \mathrm{~ns}$ |
| Input Evaluation Level | $: 2.0 \mathrm{~V} / 0.8 \mathrm{~V}$ |
| Output Evaluation Level | $: 2.0 \mathrm{~V} / 0.8 \mathrm{~V}$ |
| Output Impedance | $: 50 \mathrm{pF}$ |

(1) Read Cycle
(within recommended operating conditions)

| Parameter | Symbol | Value |  | Unit |
| :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Max |  |
| Read Cycle time | tra | 150 | - | ns |
| $\overline{\mathrm{CE}} 1$ Active Time | tcai | 120 | - | ns |
| CE2 Active Time | tca2 | 120 | - | ns |
| $\overline{\text { OE Active Time }}$ | trp | 120 | - | ns |
| $\overline{\overline{L B}}, \overline{\mathrm{UB}}$ Active Time | tBp | 120 | - | ns |
| Precharge Time | tpc | 20 | - | ns |
| Address Setup Time | tas | 0 | - | ns |
| Address Hold Time | taH | 50 | - | ns |
| $\overline{\text { OE Setup Time }}$ | tes | 0 | - | ns |
| $\overline{\mathrm{LB}}, \overline{\mathrm{UB}}$ Setup Time | tBs | 5 | - | ns |
| Output Data Hold time | tor | 0 | - | ns |
| Output Set Time | tız | 30 | - | ns |
| CE1 Access Time | tcE1 | - | 100 | ns |
| CE2 Access Time | tcE2 | - | 100 | ns |
| $\overline{O E}$ Access Time | toe | - | 100 | ns |
| Output Floating Time | torz | - | 20 | ns |

## MB85R1002A

(2) Write Cycle
(within recommended operating conditions)

| Parameter | Symbol | Value |  | Unit |
| :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Max |  |
| Write Cycle Time | twc | 150 | - | ns |
| CE1 Active Time | tca1 | 120 | - | ns |
| CE2 Active Time | tca2 | 120 | - | ns |
| $\overline{\mathrm{LB}}, \overline{\mathrm{UB}}$ Active Time | tBP | 120 | - | ns |
| Precharge Time | tpc | 20 | - | ns |
| Address Setup Time | $\mathrm{tas}_{\text {A }}$ | 0 | - | ns |
| Address Hold Time | $\mathrm{t}_{\text {AH }}$ | 50 | - | ns |
| $\overline{\overline{L B}}, \overline{\mathrm{UB}}$ Setup Time | tBS | 5 | - | ns |
| Write Pulse Width | twp | 120 | - | ns |
| Data Setup Time | tos | 0 | - | ns |
| Data Hold Time | toh | 50 | - | ns |
| Write Setup Time | tws | 0 | - | ns |

## 3. Pin Capacitance

| Parameter | Symbol | Condition | Value |  |  | Unit |
| :--- | :---: | :--- | :---: | :---: | :---: | :---: |
|  |  |  | Min | Typ | Max |  |
| Input Capacitance | $\mathrm{C}_{\mathrm{IN}}$ | $\mathrm{V}_{\mathrm{IN}}=\mathrm{V}$ out $^{2}=0 \mathrm{~V}$, | - | - | 10 | pF |
| Output Capacitance | $\mathrm{C}_{\text {OUT }}$ | $\mathrm{f}=1 \mathrm{MHz}, \mathrm{T}_{\mathrm{A}}=+25^{\circ} \mathrm{C}$ | - | - | 10 | pF |

## ■ TIMING DIAGRAMS

1. Read Cycle Timing ( $\overline{\mathrm{CE}} 1, \mathrm{CE} 2$ Control)


## 2. Read Cycle Timing ( $\overline{\mathrm{OE}}$ Control)



## MB85R1002A

3. Write Cycle Timing ( $\overline{C E} 1, \mathrm{CE} 2$ Control)

4. Write Cycle Timing ( $\overline{\mathrm{WE}}$ Control)


## POWER ON/OFF SEQUENCE


*: CE1 (Max) < Vcc +0.5 V
Notes: • Use either of $\overline{C E} 1$ or CE2, or both for disable control of the device.

- Because turning the power on from an intermediate level may cause malfunctions, when the power is turned on, Vcc is required to be started from 0 V .
- If the device does not operate within the specified conditions of read cycle, write cycle, power on/off sequence, memory data can not be guaranteed.
- When turning the power on or off, it is recommended that CE2 is connected to ground to prevent unexpected writing.
(within recommended operating conditions)

| Parameter | Symbol | Value |  |  | Unit |
| :--- | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Typ | Max |  |
| $\overline{\text { CE1 LEVEL hold time for Power OFF }}$ | tpd | 85 | - | - | ns |
| $\overline{\text { CE1 LEVEL hold time for Power ON }}$ | tpu | 85 | - | - | ns |
| Power supply rising time | tr | 0.05 | - | 200 | ms |

## NOTES ON USE

After the IR reflow completed, it is not guaranteed to hold the data written prior to the IR reflow.

## MB85R1002A

ORDERING INFOMATION

| Part number | Package |
| :---: | :---: |
| MB85R1002ANC-GE1 | 48-pin plastic TSOP(1) |
| (FPT-48P-M48) |  |

## PACKAGE DIMENSIONS

| 48-pin plastic TSOP | Lead pitch | 0.50 mm |
| :---: | :---: | :---: |
|  | Package width $\times$ package length | $12.00 \mathrm{~mm} \times 12.40 \mathrm{~mm}$ |
|  | Lead shape | Gullwing |
|  | Sealing method | Plastic mold |
|  | Mounting height | 1.20 mm MAX |
|  | Weight | 0.36 g |
| (FPT-48P-M48) |  |  |



Please check the latest package dimension at the following URL.
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## MB85R1002A

MEMO

## MEMO

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